

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/520,908	YIFRAH ET AL.	
	Examiner	Art Unit	
	Marlon A. Arce-Diaz	3611	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
see	attach	3/23/2007	MAA